

Notice of References Cited

Application/Control No.

09/928,975

Applicant(s)/Patent Under

Reexamination

HERNER ET AL.

Examiner

Thomas J. Magee

Art Unit

2811

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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